## General Description

8 P391208 is intended to take 1 or 2 reference clocks, select between them, using a pin selection and generate up to 8 outputs that are the same as the reference frequency.

8P391208 supports two output banks, each with its own power supply. All outputs in one bank would generate the same output frequency, and each bank can be individually controlled for output type or output enable.

The device can operate over the $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ temperature range.

## Features

- Two differential inputs support LVPECL, LVDS, HCSL or LVCMOS reference clocks
- Accepts input frequencies ranging from 1PPS (1Hz) to 700 MHz (up to 1 GHz when configured into HCSL output mode at 3.3 V )
- Select which of the two input clocks is to be used as the reference clock for which bank via pin selection
- Generates 8 differential outputs
- Differential outputs selectable as LVPECL, LVDS, CML or HCSL
- CML mode supports two different voltage swings
- Differential outputs support frequencies from 1PPS to 700 MHz (up to 1 GHz when configured into HCSL output mode at 3.3 V )
- Outputs arranged in 2 banks of 4 outputs each
- Each bank supports a separate power supply of $3.3 \mathrm{~V}, 2.5 \mathrm{~V}$ or 1.8 V
- Controlled by 3-level input pins
- Input mux selection control pin
- Control inputs are 3.3 V -tolerant for all core voltages
- Output noise floor of $-153 \mathrm{dBc} / \mathrm{Hz} @ 156.25 \mathrm{MHz}$
- Core voltage supply of $3.3 \mathrm{~V}, 2.5 \mathrm{~V}$ or 1.8 V
- $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ ambient operating temperature
- Lead-free (RoHS 6) packaging


## 8P391208 Block Diagram



## Pin Assignment

Figure 1: 8P391208 Pin Assignment for $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ 32-pin VFQFN Package


## Pin Description and Characteristic Tables

## Table 1: Pin Description

| Number | Name | Type ${ }^{[1]}$ |  | Description |
| :---: | :---: | :---: | :---: | :---: |
| 1 | IOA1 | Input | Pullup / Pulldown | Controls output functions for Bank A. 3-level input. |
| 2 | QA0 | Output |  | Positive differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 3 | nQA0 | Output |  | Negative differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 4 | QA1 | Output |  | Positive differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 5 | nQA1 | Output |  | Negative differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 6 | $\mathrm{V}_{\text {CCOA }}$ | Power |  | Output voltage supply for Output Bank A. |
| 7 | QA2 | Output |  | Positive differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 8 | nQA2 | Output |  | Negative differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 9 | QA3 | Output |  | Positive differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 10 | nQA3 | Output |  | Negative differential clock output. Included in Bank A. Refer to Output Drivers section for more details. |
| 11 | nc | Unused |  | Unused. Do not connect. |
| 12 | $\mathrm{V}_{\mathrm{CC}}$ | Power |  | Core Logic voltage supply. |
| 13 | CLK_SEL | Input | Pullup / Pulldown | Input Clock Selection Control pin. 3-level input. This pin's function is described in the Input Selection section. |
| 14 | nc | Unused |  | Unused. Do not connect. |
| 15 | nQB3 | Output |  | Negative differential clock output. Included in Bank B. Refer to Output Drivers section for more details. |
| 16 | QB3 | Output |  | Positive differential clock output. Included in Bank B. Refer to Output Drivers section for more details. |
| 17 | nQB2 | Output |  | Negative differential clock output. Included in Bank B. Refer to Output Drivers section for more details. |
| 18 | QB2 | Output |  | Positive differential clock output. Included in Bank B. Refer to Output Drivers section for more details. |
| 19 | $\mathrm{V}_{\text {CCOB }}$ | Power |  | Output voltage supply for Output Bank B. |
| 20 | nQB1 | Output |  | Negative differential clock output. Included in Bank B. Refer to Output Drivers section for more details. |
| 21 | QB1 | Output |  | Positive differential clock output. Included in Bank B. Refer to Output Drivers section for more details. |

Table 1: Pin Description (Continued)

| 22 | nQB0 | Output |  | Negative differential clock output. Included in Bank B. <br> Refer to Output Drivers section for more details. |
| :---: | :---: | :---: | :---: | :--- |
| 23 | QB0 | Output |  | Positive differential clock output. Included in Bank B. <br> Refer to Output Drivers section for more details. |
| 24 | IOB1 | Input | Pullup / <br> Pulldown | Controls output functions for Bank B. 3-level input. |
| 25 | CLK1 | Input | Pulldown | Non-inverting differential clock input. |
| 26 | nCLK1 | Input | Pullup / <br> Pulldown | Inverting differential clock input. $V_{C C}$ /2 when left floating (set by the internal <br> pullup and pulldown resistors). |
| 27 | VCC $^{27}$ | Power |  | Core Logic voltage supply. |
| 28 | IOB0 | Input | Pullup / <br> Pulldown | Controls output functions for Bank B. 3-level input. |
| 30 | IOA0 | Input | Pullup / <br> Pulldown | Controls output functions for Bank A. 3-level input. |
| 31 | nCLK0 | Input | Pullup / <br> Pulldown | Inverting differential clock input. VCC 2 2 when left floating (set by the internal <br> pullup and pulldown resistors). |
| 32 | CLK0 | Input | Pulldown | Non-inverting differential clock input. |
| EP | $V_{\text {EE }}$ | Ground |  | Exposed pad must be connected to GND. |

1. Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

Table 2: Pin Characteristics

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {IN }}$ | Input Capacitance |  |  |  | 2 |  | pF |
| $\mathrm{C}_{\text {PD }}$ | Power Dissipation Capacitance (per output pair) | LVPECL | $\mathrm{V}_{\text {CCOx }}{ }^{[1]}=3.465 \mathrm{~V}$ or 2.625 V |  | 2.0 |  | pF |
|  |  | LVDS |  |  |  |  | pF |
|  |  | CML, 400 mV |  |  |  |  | pF |
|  |  | CML, 800mV |  |  |  |  | pF |
|  | $\begin{aligned} & \text { QA[0:3], nQA[0:3]; } \\ & \text { QB[0:3], nQB[0:3] } \end{aligned}$ | LVPECL | $\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=1.89 \mathrm{~V}$ |  | 2.5 |  | pF |
|  |  | LVDS |  |  |  |  | pF |
|  |  | CML, 400mV |  |  |  |  | pF |
|  |  | CML, 800mV |  |  |  |  | pF |
| R PULLUP | Input Pullup Resistor |  |  |  | 51 |  | $\mathrm{k} \Omega$ |
| R PULLDOWN | Input Pulldown Resistor |  |  |  | 51 |  | $k \Omega$ |

1. $\mathrm{V}_{\mathrm{CCOx}}$ refers to $\mathrm{V}_{\mathrm{CCOA}}$ for $\mathrm{QA}[3: 0]$, $\mathrm{nQA}[3: 0]$ or $\mathrm{V}_{\mathrm{CCOB}}$ for $\mathrm{QB}[3: 0], \mathrm{nQB}[3: 0]$.

## Principles of Operation

## Input Selection

The 8P391208 supports two input references: CLK0 and CLK1 that may be driven with differential or single-ended clock signals. Either may be used as the source frequency for either or both output banks under control of the CLK_SEL input pin.

Table 3: Input Selection Control

| CLK_SEL | Description |
| :---: | :--- |
| High | Banks A \& B Both Driven from CLK1 |
| Middle $^{[1]}$ | Bank A Driven from CLK0 \& Bank B Driven from CLK1 |
| Low | Banks A \& B Both Driven from CLK0 |

1. A 'middle' voltage level is defined in Table 10. Leaving the input pin open will also generate this level via a weak internal resistor network.

## Output Drivers

The $\mathrm{QA}[0: 3]$ and $\mathrm{QB}[0: 3]$ clock outputs are provided with pin-controlled output drivers. The following table shows how each bank can be controlled. Each bank is separately controlled and all outputs within a single bank will behave the same way.

Table 4: Output Mode and Enable Control

| IOx[1] | IOx[0] | Output Bank Function |
| :---: | :---: | :--- |
| High | High | All outputs in the bank are high-impedance |
| High | Middle | All outputs in the bank are LVPECL |
| High | Low | All outputs in the bank are LVDS |
| Middle | High | All outputs in the bank are CML (400mV) |
| Middle | Middle | All outputs in the bank are high-impedance |
| Middle | Low | All outputs in the bank are HCSL |
| Low | High | All outputs in the bank are CML (800mV) |
| Low | Middle | All outputs in the bank are LVPECL |
| Low | Low | All outputs in the bank are high-impedance |

CML operation supports both a 400 mV (pk-pk) swing and an 800 mV (pk-pk) swing selection.
The operating voltage ranges of each output is determined by its independent output power pin ( $\mathrm{V}_{\mathrm{CCOA}}$ or $\mathrm{V}_{\mathrm{CCOB}}$ ) and thus each can have different output voltage levels. Output voltage levels of $1.8 \mathrm{~V}, 2.5 \mathrm{~V}$ or 3.3 V are supported for differential operation.

## Absolute Maximum Ratings

NOTE: Stresses beyond those listed under $\boldsymbol{A b s o l u t e ~ M a x i m u m ~ R a t i n g s ~ m a y ~ c a u s e ~ p e r m a n e n t ~ d a m a g e ~ t o ~ t h e ~ d e v i c e . ~ T h e s e ~ r a t i n g s ~ a r e ~}$ stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the DC
Characteristics or AC Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Table 5: Absolute Maximum Ratings

| Item | Rating |
| :--- | :--- |
| Supply Voltage, $\mathrm{V}_{\mathrm{CCX}}{ }^{[1]}$ to GND | 3.6 V |
| Inputs IOA[1:0], IOB[1:0], CLK_SEL, CLK0, nCLK0, CLK1, nCLK1 | -0.5 V to 3.6 V |
| Outputs, $\mathrm{I}_{0} \mathrm{QA}[0: 3]$, nQA[0:3]; QB[0:3], nQB[0:3] |  |
| Continuous Current | 40 mA |
| Surge Current | 60 mA |
| Outputs, $\mathrm{V}_{\mathrm{O}} \mathrm{QA}[0: 3]$, nQA[0:3]; QB[0:3], nQB[0:3] | -0.5 V to 3.6 V |
| Operating Junction Temperature | $125^{\circ} \mathrm{C}$ |
| Storage Temperature, $\mathrm{T}_{\text {STG }}$ | $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |
| Lead Temperature (Soldering, 10s) | $+260^{\circ} \mathrm{C}$ |

1. $\mathrm{V}_{\mathrm{CCX}}$ denotes $\mathrm{V}_{\mathrm{CC}}, \mathrm{V}_{\mathrm{CCOA}}$, or $\mathrm{V}_{\mathrm{CCOB}}$.

## Supply Voltage Characteristics

Table 6: Power Supply Characteristics, $\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CC }}$ | Core Supply Voltage |  | 3.135 | 3.3 | 3.465 | V |
| $\mathrm{~V}_{\text {CCOx }}$ | Output Supply Voltage |  | 3.135 | 3.3 | 3.465 | V |
| $\mathrm{I}_{\mathrm{CC}}$ | Core Supply Current | All Outputs Configured for LVDS Logic Levels; <br> Outputs Unloaded |  | 22 | 25 | mA |
| $\mathrm{I}_{\text {ccox }}$ | Output Supply Current ${ }^{[2]}$ | All Outputs Configured for LVDS Logic Levels; <br> Outputs Unloaded |  | 139 | 157 | mA |

1. NOTE 1. $\mathrm{V}_{\text {CCOX }}$ denotes $\mathrm{V}_{\text {CCOA }}, \mathrm{V}_{\text {CCOB }}$.
2. Internal dynamic switching current at maximum $\mathrm{f}_{\mathrm{OUT}}$ is included.

Table 7: Power Supply Characteristics, $\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=2.5 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CC }}$ | Core Supply Voltage |  | 2.375 | 2.5 | 2.625 | V |
| $\mathrm{~V}_{\text {CCOx }}$ | Output Supply Voltage |  | 2.375 | 2.5 | 2.625 | V |
| $\mathrm{I}_{\mathrm{CC}}$ | Core Supply Current | All Outputs Configured for LVDS Logic Levels; <br> Outputs Unloaded |  | 19 | 22 | mA |
| $\mathrm{I}_{\text {ccox }}$ | Output Supply Current ${ }^{[2]}$ | All Outputs Configured for LVDS Logic Levels; <br> Outputs Unloaded |  | 137 | 154 | mA |

1. NOTE 1. $\mathrm{V}_{\text {CCOX }}$ denotes $\mathrm{V}_{\text {CCOA }}, \mathrm{V}_{\text {CCOB }}$.
2. Internal dynamic switching current at maximum $\mathrm{f}_{\mathrm{OUT}}$ is included.

Table 8：Power Supply Characteristics， $\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Core Supply Voltage |  | 1.71 | 1.8 | 1.89 | V |
| $\mathrm{~V}_{\text {CCOx }}$ | Output Supply Voltage |  | 1.71 | 1.8 | 1.89 | V |
| $\mathrm{I}_{\mathrm{CC}}$ | Core Supply Current | All Outputs Configured for LVDS Logic Levels； <br> Outputs Unloaded |  | 15 | 17 | mA |
| $\mathrm{I}_{\text {coox }}$ | Output Supply Current ${ }^{[2]}$ | All Outputs Configured for LVDS Logic Levels； <br> Outputs Unloaded |  | 125 | 141 | mA |

1．NOTE 1． $\mathrm{V}_{\mathrm{CCOX}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$ ．
2．Internal dynamic switching current at maximum $\mathrm{f}_{\mathrm{OUT}}$ is included．

Table 9：Typical Output Supply Current， $\mathrm{V}_{\mathrm{CC}}=\mathbf{3 . 3 V}, 2.5 \mathrm{~V}$ or $1.8 \mathrm{~V}, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$

| $\bar{o}$हैに | E©\＃idd |  | $\mathrm{V}_{\text {ccox }}{ }^{[2]}=3.3 \mathrm{~V}$ |  |  |  |  | $\mathrm{V}_{\mathrm{CCOx}}{ }^{[2]}=2.5 \mathrm{~V}$ |  |  |  |  | $\mathrm{V}_{\mathrm{ccox}}{ }^{[2]}=1.8 \mathrm{~V}$ |  |  |  |  | $\frac{9}{5}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\begin{aligned} & \text { d } \\ & \sum_{j}^{n} \end{aligned}$ | $\underbrace{8}_{s}$ | $\begin{aligned} & \text { ⿹勹龴 } \\ & \underline{1} \end{aligned}$ | $\begin{aligned} & \sum_{E} \\ & \text { 首 } \\ & \sum_{0}^{5} \end{aligned}$ | $\begin{aligned} & \text { S } \\ & \text { 镸 } \\ & \text { E } \end{aligned}$ | $\begin{aligned} & 0 \\ & \sum_{j}^{0} \\ & \hline \end{aligned}$ | $\underbrace{8}_{3}$ | $\begin{aligned} & \text { ⿹勹龴 } \\ & \mathbf{1} \end{aligned}$ | $\begin{aligned} & \text { sig } \\ & \text { 要 } \\ & \text { E } \end{aligned}$ |  | $\begin{aligned} & \text { d } \\ & \text { N } \\ & \end{aligned}$ | $\underbrace{8}_{s}$ | $\begin{aligned} & \text { ⿹勹龴 } \\ & \underline{1} \end{aligned}$ |  | $\begin{aligned} & \text { S } \\ & \text { 啚 } \\ & \text { E } \end{aligned}$ |  |
| $I_{\text {CCOA }}$ | Bank A <br> Output <br> Supply <br> Current | Outputs <br> Unloaded | 50 | 66 | 41 | 33 | 33 | 49 | 65 | 37 | 31 | 31 | 43 | 28 | 31 | 27 | 27 | mA |
| ${ }^{\text {CCOB }}$ | Bank B <br> Output <br> Supply <br> Current | Outputs Unloaded | 50 | 66 | 41 | 33 | 33 | 49 | 65 | 37 | 31 | 31 | 43 | 28 | 31 | 27 | 27 | mA |

1．Internal dynamic switching current at maximum $f_{\text {OUT }}$ is included．
2． $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}$ ，or $\mathrm{V}_{\mathrm{CCOB}}$ ．

## DC Electrical Characteristics

Table 10: LVCMOSILVTTL Control / Status Signals DC Characteristics for 3-Level Pins, $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$, $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

|  | Parameter | Signals | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{1 \mathrm{H}}$ | Input <br> High Voltage | CLK_SEL, IOA[1:0], IOB[1:0] | $\mathrm{V}_{\text {CC }}=3.3 \mathrm{~V}$ | $0.85 * V_{\text {CC }}$ |  | 3.465 | V |
|  |  |  | $\mathrm{V}_{\text {CC }}=2.5 \mathrm{~V}$ | $0.85 * \mathrm{~V}_{\text {CC }}$ |  | 2.625 | V |
|  |  |  | $\mathrm{V}_{\text {CC }}=1.8 \mathrm{~V}$ | $0.85 * V_{\text {CC }}$ |  | 1.89 | V |
| $\mathrm{V}_{\text {IM }}$ | Input Middle Voltage ${ }^{[1]}$ | CLK_SEL, IOA[1:0], IOB[1:0] | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ | $0.45 * V_{\text {CC }}$ |  | $0.55 * V_{\text {CC }}$ | V |
|  |  |  | $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V}$ | $0.45 * V_{\text {CC }}$ |  | $0.55 * V_{\text {CC }}$ | V |
|  |  |  | $\mathrm{V}_{\text {CC }}=1.8 \mathrm{~V}$ | $0.45 * V_{\text {CC }}$ |  | $0.55 * V_{\text {CC }}$ | V |
| $\mathrm{V}_{\text {IL }}$ | Input <br> Low Voltage | CLK_SEL, IOA[1:0], IOB[1:0], | $\mathrm{V}_{\text {CC }}=3.3 \mathrm{~V}$ | -0.3 |  | $0.15 * V_{\text {CC }}$ | V |
|  |  |  | $\mathrm{V}_{\text {CC }}=2.5 \mathrm{~V}$ | -0.3 |  | $0.15 * V_{\text {CC }}$ | V |
|  |  |  | $\mathrm{V}_{\text {CC }}=1.8 \mathrm{~V}$ | -0.3 |  | $0.15 * V_{\text {CC }}$ | V |
| $\mathrm{I}_{\mathrm{H}}$ | Input <br> High Current | CLK_SEL, IOA[1:0], IOB[1:0] | $\begin{gathered} \mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\text {IN }}=3.465 \mathrm{~V} \text { or } \\ 2.625 \mathrm{~V} \text { or } 1.89 \mathrm{~V} \end{gathered}$ |  |  | 150 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\text {M }}$ | Input <br> Middle Current | CLK_SEL, IOA[1:0], IOB[1:0] | $\begin{gathered} \mathrm{V}_{\mathrm{CC}}=3.465 \mathrm{~V} \text { or } \\ 2.625 \mathrm{~V} \text { or } 1.89 \mathrm{~V}, \\ \mathrm{~V}_{\text {IN }}=\mathrm{V}_{\mathrm{CC}} / 2 \end{gathered}$ | -10 |  | 10 | $\mu \mathrm{A}$ |
| IIL | Input <br> Low Current | CLK_SEL, IOA[1:0], IOB[1:0], | $\begin{gathered} \mathrm{V}_{\mathrm{CC}}=3.465 \mathrm{~V} \text { or } \\ 2.625 \mathrm{~V} \text { or } 1.89 \mathrm{~V}, \mathrm{~V}_{\mathrm{IN}}=0 \mathrm{~V} \end{gathered}$ | -150 |  |  | $\mu \mathrm{A}$ |

1. For 3 -level input pins, a mid-level voltage is used to select the $3^{\text {rd }}$ state. This voltage will be maintained by a weak internal pull-up / pull-down network for each pin to select this state if the pin is left open. It is recommended that any external resistor networks used to select a middle-level input voltage be terminated to the device's core $\mathrm{V}_{\mathrm{CC}}$ voltage level.

Table 11: Differential Input DC Characteristics, $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}$, $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{H}}$ | Input High Current | CLKX, nCLKx ${ }^{[1]}$ | $\mathrm{V}_{\text {CC }}=\mathrm{V}_{\text {IN }}=3.465 \mathrm{~V}$ or 2.625 V |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input Low Current | CLKx ${ }^{[1]}$ | $\mathrm{V}_{\text {CC }}=3.465 \mathrm{~V}$ or $2.625 \mathrm{~V}, \mathrm{~V}_{\text {IN }}=0 \mathrm{~V}$ | -5 |  |  | $\mu \mathrm{A}$ |
|  |  | nCLKx ${ }^{[1]}$ | $\mathrm{V}_{\mathrm{CC}}=3.465 \mathrm{~V}$ or 2.625V, $\mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ | -150 |  |  | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\mathrm{PP}}$ | Peak-to-Peak Voltage ${ }^{[2]}$ |  |  | 0.2 |  | 1.3 | V |
| $\mathrm{V}_{\text {CMR }}$ | Common Mode Input Voltage ${ }^{[2]]}$ [3] |  |  | $\mathrm{V}_{\mathrm{EE}}$ |  | $\mathrm{V}_{\text {CC }}-1.2$ | V |

1. CLKx denotes CLK0, CLK1. nCLKx denotes nCLK0, nCLK1.
2. $\mathrm{V}_{\mathrm{IL}}$ should not be less than -0.3 V . $\mathrm{V}_{\mathrm{IH}}$ should not be higher than $\mathrm{V}_{\mathrm{CC}}$.
3. Common mode voltage is defined as the cross-point.

Table 12: LVPECL DC Characteristics, $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}$, $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | $\mathrm{V}_{\text {CCOx }}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%$ |  |  | $\mathrm{V}_{\text {CCOx }}{ }^{[1]}=2.5 \mathrm{~V} \pm 5 \%$ |  |  | $\mathrm{V}_{\text {ccox }}{ }^{[1]}=1.8 \mathrm{~V} \pm 5 \%$ |  |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{V}_{\mathrm{OH}}$ | Output High Voltage ${ }^{[2]}$ | $\begin{aligned} & \mathrm{Qx}, \\ & \mathrm{nQx} x^{[3]} \end{aligned}$ | $\begin{gathered} \mathrm{V}_{\mathrm{Ccox}} \\ 1.3 \end{gathered}$ |  | $\begin{gathered} \mathrm{V}_{\text {ccox }}-{ }_{0}=0.8 \end{gathered}$ | $\begin{gathered} V_{\text {Ccox }}{ }^{-} \\ 1.35 \end{gathered}$ |  | $\begin{gathered} \mathrm{V}_{\text {ccox }}-{ }_{0.9}-2 \end{gathered}$ | $\begin{gathered} V_{\text {Ccox }}{ }^{-} \\ 1.50 \end{gathered}$ |  | $\begin{gathered} \mathrm{V}_{\mathrm{ccox}}- \\ 0.9 \end{gathered}$ | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Output Low Voltage ${ }^{[2]}$ | Qx, nQx ${ }^{[2]}$ | $\mathrm{V}_{\mathrm{CCOx}}-2$ |  | $\begin{gathered} \mathrm{V}_{\mathrm{ccox}}{ }^{-} \\ 1.75 \end{gathered}$ | $\mathrm{V}_{\mathrm{CcOx}}{ }^{-}$ |  | $\begin{gathered} \mathrm{V}_{\mathrm{ccox}}-{ }^{-} \\ 1.75 \end{gathered}$ | $V_{\text {EE }}$ |  | 0.25 | V |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Outputs terminated with $50 \Omega$ to $\mathrm{V}_{\mathrm{CCOx}}-2 \mathrm{~V}$ when $\mathrm{V}_{\mathrm{CCOX}}=3.3 \mathrm{~V} \pm 5 \%$ or $2.5 \mathrm{~V} \pm 5 \%$. Outputs terminated with $50 \Omega$ to ground when $\mathrm{V}_{\mathrm{CCOX}}$ $=1.8 \mathrm{~V} \pm 5 \%$.
3. Qx denotes $\mathrm{QA} 0, \mathrm{QA1}, \mathrm{QA} 2, \mathrm{QA} 3, \mathrm{QB} 0, \mathrm{QB} 1, \mathrm{QB} 2, \mathrm{QB} 3 . n Q x$ denotes $n Q A 0, n Q A 1, n Q A 2, n Q A 3, n Q B 0, n Q B 1, n Q B 2, n Q B 3$.

Table 13: LVDS DC Characteristics, $\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}^{[1]}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OD}}$ | Differential Output Voltage | Qx, nQx ${ }^{[2]}$ | Terminated $100 \Omega$ across Qx and nQx | 195 |  | 480 | mV |
| $\Delta \mathrm{V}_{\mathrm{OD}}$ | $V_{\text {OD }}$ Magnitude Change | Qx, nQx ${ }^{[2]}$ |  |  |  | 50 | mV |
| $\mathrm{V}_{\text {OS }}$ | Offset Voltage | Qx, nQx ${ }^{[2]}$ |  | 1.1 |  | 1.375 | V |
| $\Delta \mathrm{V}_{\mathrm{OS}}$ | $\mathrm{V}_{\text {OS }}$ Magnitude Change | Qx, nQx ${ }^{[2]}$ |  |  |  | 50 | mV |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Qx denotes $\mathrm{QA} 0, \mathrm{QA} 1, \mathrm{QA} 2, \mathrm{QA} 3, \mathrm{QB} 0, \mathrm{QB} 1, \mathrm{QB} 2, \mathrm{QB} 3$.
nQx denotes nQA0, nQA1, nQA2, nQA3, nQB0, nQB1, nQB2, nQB3.

Table 14: LVDS DC Characteristics, $\mathrm{V}_{\mathrm{CCO}}{ }^{[1]}=2.5 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {OD }}$ | Differential Output Voltage | Qx, nQx ${ }^{[2]}$ | Terminated $100 \Omega$ across Qx and nQx | 195 |  | 470 | mV |
| $\Delta \mathrm{V}_{\text {OD }}$ | $V_{\text {OD }}$ Magnitude Change | Qx, $\mathrm{nQx}{ }^{[2]}$ |  |  |  | 50 | mV |
| $\mathrm{V}_{\text {OS }}$ | Offset Voltage | Qx, nQx ${ }^{[2]}$ |  | 1.1 |  | 1.375 | V |
| $\Delta \mathrm{V}_{\text {OS }}$ | $\mathrm{V}_{\text {OS }}$ Magnitude Change | Qx, nQx ${ }^{[2]}$ |  |  |  | 50 | mV |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Qx denotes $\mathrm{QA} 0, \mathrm{QA} 1, \mathrm{QA} 2, \mathrm{QA} 3, \mathrm{QB} 0, \mathrm{QB} 1, \mathrm{QB} 2, \mathrm{QB} 3$.
$n Q x$ denotes nQA0, nQA1, nQA2, nQA3, nQB0, nQB1, nQB2, nQB3.

Table 15: LVDS DC Characteristics, $\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $V_{O D}$ | Differential Output Voltage | $\mathrm{Qx}, \mathrm{nQx}{ }^{[2]}$ | Terminated $100 \Omega$ across Qx and nQx | 195 |  | 454 | mV |
| $\Delta \mathrm{V}_{\text {OD }}$ | $V_{O D}$ Magnitude Change | Qx, nQx ${ }^{[2]}$ |  |  |  | 50 | mV |
| $\mathrm{V}_{\text {OS }}$ | Offset Voltage | Qx, nQx ${ }^{[2]}$ |  | 1.1 |  | 1.375 | V |
| $\Delta \mathrm{V}_{\text {OS }}$ | $V_{\text {OS }}$ Magnitude Change | Qx, nQx ${ }^{[2]}$ |  |  |  | 50 | mV |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\text {CCOA }}, \mathrm{V}_{\text {CCOB }}$.
2. Qx denotes $\mathrm{QA} 0, \mathrm{QA} 1, \mathrm{QA} 2, \mathrm{QA} 3, \mathrm{QB} 0, \mathrm{QB} 1, \mathrm{QB} 2, \mathrm{QB} 3$.
nQx denotes nQA0, nQA1, nQA2, nQA3, nQB0, nQB1, nQB2, nQB3.

Table 16: CML ( 400 mV Swing) DC Characteristics, $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%$, $\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | Output High Voltage | Qx, nQx ${ }^{[2]}$ | Terminated with $50 \Omega$ to$V_{C C O x}$ | $\mathrm{V}_{\text {CCOx }}-0.1$ |  | $\mathrm{V}_{\mathrm{CcOx}}$ | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Output Low Voltage | Qx, nQx ${ }^{[2]}$ |  | $\mathrm{V}_{\text {CCOx }}-0.5$ |  | $V_{\text {CCOx }}-0.3$ | V |
| $\mathrm{V}_{\text {OUT }}$ | Output Voltage Swing | $\mathrm{Qx}, \mathrm{nQx}{ }^{[2]}$ |  | 300 |  | 500 | mV |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Qx denotes $\mathrm{QA} 0, \mathrm{QA} 1, \mathrm{QA} 2, \mathrm{QA} 3, \mathrm{QB} 0, \mathrm{QB} 1, \mathrm{QB} 2, \mathrm{QB} 3$.
nQx denotes nQA0, nQA1, nQA2, nQA3, nQB0, nQB1, nQB2, nQB3.

Table 17: CML ( 800 mV Swing) DC Characteristics, $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%$,
$\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | Output High Voltage | Qx, nQx ${ }^{[2]}$ | Terminated with $50 \Omega$ to $\mathrm{V}_{\mathrm{CCOx}}$ | $\mathrm{V}_{\text {ccox }}-0.1$ |  | $\mathrm{V}_{\text {ccox }}$ | V |
| $\mathrm{V}_{\text {OL }}$ | Output Low Voltage | Qx, nQx ${ }^{[2]}$ |  | $\mathrm{V}_{\text {CCOx }}-0.95$ |  | $V_{\text {CCOx }}-0.7$ | V |
| $\mathrm{V}_{\text {OUT }}$ | Output Voltage Swing | $\mathrm{Qx}, \mathrm{nQx}{ }^{[2]}$ |  | 575 |  | 1000 | mV |

1. $\mathrm{V}_{\mathrm{CCOX}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Qx denotes $\mathrm{QA0}, \mathrm{QA1}, \mathrm{QA} 2, \mathrm{QA} 3, \mathrm{QB} 0, \mathrm{QB} 1, \mathrm{QB} 2, \mathrm{QB} 3$.
nQx denotes nQA0, nQA1, nQA2, nQA3, nQB0, nQB1, nQB2, nQB3.

Table 18: HCSL DC Characteristics, $\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\mathrm{CCOA}}=\mathrm{V}_{\mathrm{CCOB}}=3.3 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}^{[1]}$, [2]

| Symbol | Parameter | Test Conditions | Minimum | Typical | Maximum | Units |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | Output High Voltage | Qx, nQx |  | 475 |  | 900 |
| $\mathrm{~V}_{\mathrm{OL}}$ | Output Low Voltage | $\mathrm{Qx}, \mathrm{nQx}$ |  | -100 |  | mV |
| $\mathrm{V}_{\text {OUT }}$ | Output Voltage Swing | $\mathrm{Qx}, \mathrm{nQx}$ |  | 475 |  | mV |

1. Guaranteed by design and Characterization, not $100 \%$ tested in production.
2. $C_{L}=2 p f, R_{S}=33.2 \Omega, R_{P}=49.9 \Omega$

Table 19: Input Frequency Characteristics, $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}$, $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions | Minimum | Typical | Maximum |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| Units |  |  |  |  |  |  |
| $\mathrm{f}_{\mathrm{IN}}$ | Input Frequency | CLKx, nCLKx ${ }^{[1],[2]}$ |  | 1 Hz |  | 700 MHz |
| idc | Input Duty Cycle ${ }^{[3]}$ |  |  | 50 |  | $\%$ |

1. CLKx denotes CLKO, CLK1. nCLKx denotes nCLK0, nCLK1.
2. Input frequency is up to 1 GHz when $\mathrm{V}_{\mathrm{CC}} / \mathrm{V}_{\mathrm{CCOx}}=3.3 \mathrm{~V} \pm 5 \%$ for HCSL output mode.
3. Any deviation from a $50 \%$ duty cycle on the input may be reflected in the output duty cycle.

## AC Electrical Characteristics

Table 20: LVDS, LVPECL, CML AC Characteristics, $\mathrm{V}_{\mathrm{Cc}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%$, $\mathrm{V}_{\mathrm{CCOx}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter ${ }^{[2]}$ |  | Test Conditions ${ }^{[3]}$ | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{f}_{\text {OUT }}$ | Output Frequency | LVDS, <br> LVPECL, CML |  | 1PPS |  | 700 | MHz |
| $t_{R} / t_{F}$ | Output Rise and Fall Times | LVPECL | 20\% to 80\% | 100 |  | 705 | ps |
|  |  | LVDS | $20 \%$ to $80 \%, \mathrm{~V}_{\text {ccox }}=3.3 \mathrm{~V}$ | 150 |  | 530 | ps |
|  |  |  | $20 \%$ to $80 \%, \mathrm{~V}_{\text {ccox }}=2.5 \mathrm{~V}$ | 165 |  | 530 | ps |
|  |  |  | $20 \%$ to $80 \%, \mathrm{~V}_{\text {ccox }}=1.8 \mathrm{~V}$ | 200 |  | 565 | ps |
|  |  | CML 400mV | 20\% to 80\% | 100 |  | 625 | ps |
|  |  | CML 800mV | 20\% to 80\% | 150 |  | 580 | ps |
| $\mathrm{t}_{\text {sk }}(\mathrm{b})$ | $\begin{aligned} & \text { Bank Skew }{ }^{[4],} \\ & {[5],[6]} \end{aligned}$ | LVPECL ${ }^{[7]}$ |  |  |  | 55 | ps |
|  |  | LVDS ${ }^{[7]}$ |  |  |  | 55 | ps |
|  |  | CML 400mV ${ }^{[7]}$ |  |  |  | 55 | ps |
|  |  | CML 800mV ${ }^{[7]}$ |  |  |  | 55 | ps |
| odc | Output Duty Cycle ${ }^{[8]}$ |  |  | 45 | 50 | 55 | \% |
| MUX ${ }_{\text {ISOL }}$ | Mux Isolation |  |  |  | 70 |  | dB |
| $\mathrm{t}_{\text {startup }}$ | Startup Time |  |  |  | 25 |  | ms |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 Ifpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
3. Tested for the following out frequencies: $100 \mathrm{MHz}, 156.25 \mathrm{MHz}, 312.5 \mathrm{MHz}, 700 \mathrm{MHz}$.
4. This parameter is guaranteed by characterization. Not tested in production.
5. This parameter is defined in accordance with JEDEC Standard 65.
6. Defined as skew within a bank of outputs at the same supply voltage and with equal load conditions.
7. Measured at the output differential crosspoint.
8. Measured using 50\% duty cycle on input reference.

Table 21: HCSL AC Characteristics, $\mathrm{f}_{\mathrm{OUT}}=100 \mathrm{MHz} \mathrm{V}_{\mathrm{Cc}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%$, $\mathrm{V}_{\mathrm{Ccox}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter ${ }^{[2]}$ | Test Conditions | Minimum | Typical | Maximum |
| :---: | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{RB}}$ | Ring-back Voltage Margin ${ }^{[3],[4]}$ |  | -100 |  | 100 |
| $\mathrm{t}_{\text {STABLE }}$ | Time before $\mathrm{V}_{\text {RB }}$ is allowed ${ }^{[3],[4]}$ | 500 |  | mV |  |
| $\mathrm{V}_{\text {MAX }}$ | Absolute Max. Output Voltage ${ }^{[5],[6]}$ |  |  | ps |  |
| $\mathrm{V}_{\text {MIN }}$ | Absolute Min. Output Voltage ${ }^{[5],[7]}$ |  | -300 |  | 1150 |
| $\mathrm{~V}_{\text {CROSS }}$ | Absolute Crossing Voltage ${ }^{[8],[9],[5]}$ |  | 200 | mV |  |
| $\Delta \mathrm{V}_{\text {CROSS }}$ | Total Variation of $\mathrm{V}_{\text {CROSS }}$ over all edge ${ }^{[8],[10],[5]}$ |  |  | 50 |  |

1. $\mathrm{V}_{\mathrm{CCOx}}$ denotes $\mathrm{V}_{\mathrm{CCOA}}, \mathrm{V}_{\mathrm{CCOB}}$.
2. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 Ifpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
3. Measurement taken from differential waveform.
4. $t_{\text {STABLE }}$ is the time the differential clock must maintain a minimum $\pm 150 \mathrm{mV}$ differential voltage after rising/falling edges before it is allowed to drop back into the $\mathrm{V}_{\mathrm{RB}} \pm 100 \mathrm{mV}$ differential range.
5. Measurement taken from single ended waveform.
6. Defined as the maximum instantaneous voltage including overshoot.
7. Defined as the minimum instantaneous voltage including undershoot.
8. Measured at crossing point where the instantaneous voltage value of the rising edge of Qx equals the falling edge of $n Q x$.
9. Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement.
10.Defined as the total variation of all crossing voltages of rising Qx and falling nQx , This is the maximum allowed variance in $\mathrm{V}_{\mathrm{CROSS}}$ for any particular system.

Table 22: HCSL Electrical Characteristics, Current Mode Differential Pair, $\mathrm{V}_{\mathrm{CC}}=\mathrm{V}_{\mathrm{CCOA}}=\mathrm{V}_{\mathrm{CCOB}}=3.3 \mathrm{~V} \pm 5 \%$, $2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}^{[1], ~[2]}$

| Symbol | Parameter | Test Conditions ${ }^{[3],}$ [4] | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OH}}$ | Output Voltage High | Statistical Measurement on Single-ended Signal using Oscilliscope Math Function | 300 |  | 950 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output Voltage Low |  | -100 |  |  | mV |
| $\mathrm{V}_{\text {MAX }}$ | Absolute Max. Output Voltage ${ }^{\text {[5], [6] }}$ |  |  |  | 1150 | mV |
| $\mathrm{V}_{\text {MIN }}$ | Absolute Min. Output Voltage ${ }^{[5],}$, 7$]$ |  | -300 |  |  | mV |
| $\mathrm{V}_{\text {CROSS }}$ | Absolute Crossing Voltage [5], [8], [9] |  | 150 |  | 550 | mV |
| $\Delta \mathrm{V}_{\text {CROSS }}$ | Total Variation of $\mathrm{V}_{\text {CROSS }}$ over all Edges [5], [8], [10] |  |  |  | 140 | mV |
| Edge Rate Rise | Rising Edge Rate ${ }^{[11],[12]}$ |  | 0.3 |  | 4.5 | V/ns |
| Edge Rate Fall | Falling Edge Rate ${ }^{[11],}$ [12] |  | 0.3 |  | 4.5 | V/ns |

1. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 Ifpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
2. Guaranteed by design and Characterization, not $100 \%$ tested in production.
3. Test configuration: $\mathrm{C}_{\mathrm{L}}=2 \mathrm{pF}, \mathrm{R}_{\mathrm{S}}=33.2 \Omega, \mathrm{R}_{\mathrm{P}}=49.9 \Omega$.
4. Tested for the following out frequencies: $156.25 \mathrm{MHz}, 245.76 \mathrm{MHz}, 312.5 \mathrm{MHz}$, and 625 MHz . For other frequencies, contact IDT Marketing.
5. Measurement taken from a single-ended waveform.
6. Defined as the maximum instantaneous voltage including overshoot.
7. Defined as the minimum instantaneous voltage including undershoot.
8. Measured at crossing point where the instantaneous voltage value of the rising edge of CLK+ equals the falling edge of CLK-.
9. Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement.
10. Defined as the total variation of all crossing voltages of rising CLK+ and falling CLK-. this is the maximum allowed variance in VCROSS for any particular system.
11. Measurement taken from a differential waveform.
12. Measured from -150 mV on the differential waveform (derived from Q minus nQ ). the signal must be monotonic through the measurement region for rise and fall time. The 300 mV measurement window is centered on the differential zero crossing.

Table 23: Typical Additive Jitter, $\mathrm{V}_{\mathrm{cc}}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$ or $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{cc}}{ }^{[1]}=3.3 \mathrm{~V} \pm 5 \%, 2.5 \mathrm{~V} \pm 5 \%$, $1.8 \mathrm{~V} \pm 5 \%, \mathrm{~V}_{\mathrm{EE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$

| Symbol | Parameter |  | Test Conditions ${ }^{[2]}$ | Minimum | Typical | Maximum | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\mathrm{jit}}(\mathrm{f})$ | RMS <br> Additive Jitter (Random) | LVPECL | $\begin{gathered} f_{\text {OUT }}=156.25 \mathrm{MHz}, \\ \text { Integration Range: } 12 \mathrm{kHz}-20 \mathrm{MHz} \end{gathered}$ |  | 62 |  | fs |
|  |  | LVDS |  |  | 82 |  | fs |
|  |  | HCSL |  |  | 74 |  | fs |
|  |  | CML, 400 mV |  |  | 68 |  | fs |
|  |  | CML, 400 mV |  |  | 65 |  | fs |

1. $V_{C C O x}$ denotes $V_{C C O A}, V_{C C O B}$.
2. All outputs configured for the specific output type, as shown in the table.

## Applications Information

## Recommendations for Unused Input and Output Pins

## Inputs:

## CLKInCLK Inputs

For applications not requiring the use of the differential input, both CLK and nCLK can be left floating. Though not required, but for additional protection, a $1 \mathrm{k} \Omega$ resistor can be tied from CLK to ground.

## LVCMOS LVTLL Level Control Pins

All control pins have internal pullups or pulldowns; additional resistance is not required but can be added for additional protection. A $1 \mathrm{k} \Omega$ resistor can be used.

## LVCMOS 3-Level I/OControl Pins

These pins are 3-level pins and if left unconnected this is interpreted as a valid input selection option (Middle).

## Outputs:

## Differential Outputs

All unused Differential outputs can be left floating. It is recommended that there is no trace attached.

## LVPECL Outputs

All unused LVPECL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

## LVDS Outputs

All unused LVDS output pairs can be either left floating or terminated with $100 \Omega$ across. If they are left floating, there should be no trace attached.

## Wiring the Differential Input to Accept Single-Ended Levels

Figure 2 shows how a differential input can be wired to accept single ended levels. The reference voltage $\mathrm{V}_{1}=\mathrm{V}_{\mathrm{CC}} / 2$ is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the $\mathrm{V}_{1}$ in the center of the input voltage swing. For example, if the input clock swing is 2.5 V and $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{R} 1$ and R 2 value should be adjusted to set $\mathrm{V}_{1}$ at 1.25 V . The values below are for when both the single ended swing and $V_{C C}$ are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission line impedance. For most $50 \Omega$ applications, R3 and R4 can be $100 \Omega$. The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced while maintaining an edge rate faster than $1 \mathrm{~V} / \mathrm{ns}$. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however $\mathrm{V}_{I L}$ cannot be less than -0.3 V and $\mathrm{V}_{I H}$ cannot be more than $\mathrm{V}_{\mathrm{CC}}+0.3 \mathrm{~V}$. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

Figure 2: Recommended Schematic for Wiring a Differential Input to Accept Single-ended Levels


### 3.3V Differential Clock Input Interface

The CLK /nCLK accepts LVDS, LVPECL, LVHSTL, HCSL and other differential signals. Both $\mathrm{V}_{\text {SWING }}$ and $\mathrm{V}_{\mathrm{OH}}$ must meet the $\mathrm{V}_{\mathrm{PP}}$ and $\mathrm{V}_{\mathrm{CMR}}$ input requirements. Figure 3 to Figure 7 show interface examples for the CLK/nCLK input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult with the vendor of the driver component to confirm the driver termination requirements. For example, in Figure 3, the input termination applies for IDT open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

Figure 3: CLK/nCLK Input Driven by an IDT Open Emitter LVHSTL Driver


Figure 4: CLK/nCLK Input Driven by a 3.3V LVPECL Driver


Figure 6: CLK/nCLK Input Driven by a 3.3V LVPECL Driver


Figure 7: CLK/nCLK Input Driven by a 3.3V HCSL Driver


Figure 5: CLK/nCLK Input Driven by a 3.3V LVDS Driver


### 2.5V Differential Clock Input Interface

CLKx/nCLKx accepts LVDS, LVPECL, LVHSTL, HCSL and other differential signals. Both $\mathrm{V}_{\text {SWING }}$ and $\mathrm{V}_{\text {OH }}$ must meet the $\mathrm{V}_{\mathrm{PP}}$ and $\mathrm{V}_{\text {CMR }}$ input requirements. Figure 8 to Figure 12 show interface examples for the CLKx/nCLKx input driven by the most common driver types. The input interfaces suggested here are examples only. Please consult with the vendor of the driver component to confirm the driver termination requirements. For example, in Figure 8, the input termination applies for IDT open emitter LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.

Figure 8: CLKx/nCLKx Input Driven by an IDT Open Emitter LVHSTL Driver


Figure 9: CLKx/nCLKx Input Driven by a 2.5V LVPECL Driver


Figure 11: CLKx/nCLKx Input Driven by a 2.5V LVPECL Driver


Figure 12: CLKx/nCLKx Input Driven by a 2.5V LVDS Driver


Figure 10: CLKx/nCLKx Input Driven by a 2.5V HCSL Driver


## LVDS Driver Termination

For a general LVDS interface, the recommended value for the termination impedance $\left(Z_{T}\right)$ is between $90 \Omega$ and $132 \Omega$. The actual value should be selected to match the differential impedance $\left(Z_{0}\right)$ of your transmission line. A typical point-to-point LVDS design uses a $100 \Omega$ parallel resistor at the receiver and a $100 \Omega$ differential transmission-line environment. In order to avoid any transmission-line reflection issues, the components should be surface mounted and must be placed as close to the receiver as possible. IDT offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The standard termination schematic as shown in Fgure 13can be used with either type of output structure. Figure 14, which can also be used with both output types, is an optional termination with center tap capacitance to help filter common mode noise. The capacitor value should be approximately 50 pF . If using a non-standard termination, it is recommended to contact IDT and confirm if the output structure is current source or voltage source type. In addition, since these outputs are LVDS compatible, the input receiver's amplitude and common-mode input range should be verified for compatibility with the output.

Figure 13: Standard LVDS Termination


Figure 14: Optional LVDS Termination


## Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential output is a low impedance follower output that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive $50 \Omega$ transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. Figure 15 and Figure 16 show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

Figure 15: 3.3V LVPECL Output Termination


Figure 16: 3.3V LVPECL Output Termination


## Termination for 2.5V LVPECL Outputs

Figure 17 and Figure 18 show examples of termination for 2.5 V LVPECL driver. These terminations are equivalent to terminating $50 \Omega$ to $\mathrm{V}_{\mathrm{CCO}}-2 \mathrm{~V}$. For $\mathrm{V}_{\mathrm{CCO}}=2.5 \mathrm{~V}$, the $\mathrm{V}_{\mathrm{CCO}}-2 \mathrm{~V}$ is very close to ground level. The R 3 in Figure 18 can be eliminated and the termination is shown in Figure 19.

Figure 17: 2.5V LVPECL Driver Termination Example


Figure 18: 2.5V LVPECL Driver Termination Example


Figure 19: 2.5V LVPECL Driver Termination Example


## Recommended Termination for HCSL Outputs

Figure 20 is the recommended source termination for applications where the driver and receiver will be on a separate PCBs. This termination is the standard for PCl Express ${ }^{\top \mathrm{TM}}$ and HCSL output types. All traces should be $50 \Omega$ impedance single-ended or $100 \Omega$ differential.

Figure 21 is the recommended termination for applications where a point-to-point connection can be used. A point-to-point connection contains both the driver and the receiver on the same PCB. With a matched termination at the receiver, transmission-line reflections will be minimized. In addition, a series resistor (Rs) at the driver offers flexibility and can help dampen unwanted reflections. The optional resistor can range from $0 \Omega$ to $33 \Omega$. All traces should be $50 \Omega$ impedance single-ended or $100 \Omega$ differential.

Figure 20: Recommended Source Termination (where the driver and receiver will be on separate PCBs)


Figure 21: Recommended Termination (where a point-to-point connection can be used)


## CML Termination

Figure 22 shows an example of the termination for a CML driver. In this example, the transmission line characteristic impedance is $50 \Omega$. The $R 1$ and $R 250 \Omega$ matched load terminations are pulled up to $V_{D D O}$. The matched loads are located close to the receiver.

Figure 22: CML Termination Example


## Power Dissipation and Thermal Considerations

The 8P391208 is a multi-functional, high speed device that targets a wide variety of clock frequencies and applications. Since this device is highly programmable with a broad range of features and functionality, the power consumption will vary as each of these features and functions is enabled.

The 8P391208 device was designed and characterized to operate within the ambient industrial temperature range of $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$. The ambient temperature represents the temperature around the device, not the junction temperature. When using the device in extreme cases, such as maximum operating frequency and high ambient temperature, external air flow may be required in order to ensure a safe and reliable junction temperature. Extreme care must be taken to avoid exceeding $125^{\circ} \mathrm{C}$ junction temperature.

The power calculation examples below were generated using a maximum ambient temperature and supply voltage. For many applications, the power consumption will be much lower. Please contact IDT technical support for any concerns on calculating the power dissipation for your own specific configuration.

## Power Domains

The 8P391208 device has a number of separate power domains that can be independently enabled and disabled via register accesses (all power supply pins must still be connected to a valid supply voltage). Figure 23 below indicates the individual domains and the associated power pins.

Figure 23: 8P391208 Power Domains


## Power Consumption Calculation

Determining total power consumption involves several steps:

1. Determine the power consumption using maximum current values for core voltage from Table 6, Table 7, Table 8 and Table 9, Page 7 for the appropriate case of how many banks or outputs are enabled.
2. Determine the nominal power consumption of each enabled output path.
a. This consists of a base amount of power that is independent of operating frequency, as shown in Table 25 through Table 36 (depending on the chosen output protocol).
b. Then there is a variable amount of power that is related to the output frequency. This can be determined by multiplying the output frequency by the FQ_Factor shown in Table 25 through Table 36.
3. All of the above totals are then summed.

## Thermal Considerations

Once the total power consumption has been determined, it is necessary to calculate the maximum operating junction temperature for the device under the environmental conditions it will operate in. Thermal conduction paths, air flow rate and ambient air temperature are factors that can affect this. The thermal conduction path refers to whether heat is to be conducted away via a heat-sink, via airflow or via conduction into the PCB through the device pads (including the ePAD). Thermal conduction data is provided for typical scenarios in Table 42, Page 36. Please contact IDT for assistance in calculating results under other scenarios.

Table 24: $\theta_{J A}$ vs. Air Flow Table for a 32 -lead $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ VFQFN

| $\theta_{\mathrm{JA}}$ vs. Air Flow |  |  |  |
| :--- | :---: | :---: | :---: |
| Meters per Second | 0 | 1 | 2 |
| Multi-Layer PCB, JEDEC Standard Test Boards | $35.23^{\circ} \mathrm{C} / \mathrm{W}$ | $31.6^{\circ} \mathrm{C} / \mathrm{W}$ | $30.0^{\circ} \mathrm{C} / \mathrm{W}$ |

## Current Consumption Data and Equations

Table 25: 3.3V LVDS Output Calculation Table

| LVDS | FQ_Factor <br> $(\mathbf{m A / M H z})$ | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.07 | 30.0 |
| Bank B | 0.07 | 30.0 |

Table 26: 2.5V LVDS Output Calculation Table

| LVDS | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.07 | 26.0 |
| Bank B | 0.07 | 26.0 |

Table 27: 1.8V LVDS Output Calculation Table

| LVDS | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.06 | 38.0 |
| Bank B | 0.06 | 38.0 |

Table 28: 3.3V LVPECL Output Calculation Table

| LVPECL | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.04 | 22.0 |
| Bank B | 0.04 | 22.0 |

Table 29: 2.5V LVPECL Output Calculation Table

| LVPECL | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.04 | 21.0 |
| Bank B | 0.04 | 21.0 |

Table 30: 1.8V LVPECL Output Calculation Table

| LVPECL | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.04 | 20.0 |
| Bank B | 0.04 | 20.0 |

Table 31: 3.3V CML Output ( 400 mV ) Calculation Table

| CML (400mV) | FQ_Factor (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.02 | 19.0 |
| Bank B | 0.02 | 19.0 |

Table 32: 2.5V CML Output ( 400 mV ) Calculation Table

| CML ( 400 mV ) | FQ_Factor <br> $(\mathrm{mA} / \mathrm{MHz})$ | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.02 | 16.0 |
| Bank B | 0.02 | 16.0 |

Table 33: 1.8V CML Output ( 400 mV ) Calculation Table

| CML (400mV) | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.02 | 15.0 |
| Bank B | 0.02 | 15.0 |

Table 34: 3.3V CML Output ( 800 mV ) Calculation Table

| CML (800mV) | FQ_Factor <br> (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.02 | 19.0 |
| Bank B | 0.02 | 19.0 |

Table 35: 2.5V CML Output ( 800 mV ) Calculation Table

| CML (800mV) | FQ_Factor (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.02 | 16.0 |
| Bank B | 0.02 | 16.0 |

Table 36: 1.8V CML Output ( 800 mV ) Calculation Table

| CML (800mV) | FQ_Factor (mA/MHz) | Base_Current (mA) |
| :---: | :---: | :---: |
| Bank A | 0.02 | 15.0 |
| Bank B | 0.02 | 15.0 |

Applying the values to the following equation will yield output current by frequency:
Qx Current $(\mathrm{mA})=$ FQ_Factor * Frequency (MHz) + Base_Current
where:
Qx Current is the specific output current according to output type and frequency
FQ_Factor is used for calculating current increase due to output frequency
Base_Current is the base current for each output path independent of output frequency
The second step is to multiply the power dissipated by the thermal impedance to determine the maximum power gradient, using the following equation:
$T_{J}=T_{A}+\left(\theta_{J A} * P d_{\text {total }}\right)$
where:
$\mathrm{T}_{\mathrm{J}}$ is the junction temperature $\left({ }^{\circ} \mathrm{C}\right)$
$\mathrm{T}_{\mathrm{A}}$ is the ambient temperature $\left({ }^{\circ} \mathrm{C}\right)$
$\theta_{\mathrm{JA}}$ is the thermal resistance value from Table 42, Page 36, dependent on ambient airflow ( ${ }^{\circ} \mathrm{C} / \mathrm{W}$ )
$\mathrm{Pd}_{\text {total }}$ is the total power dissipation of the 8P391208 under usage conditions, including power dissipated due to loading (W)
Note that for LVPECL outputs the power dissipation through the load is assumed to be 27.95 mW ).

## Example Calculations

Table 37: Example 1 - Common Customer Configuration (3.3V Core Voltage)

|  | Configuration | Frequency (MHz) | $\mathbf{V}_{\text {CCo }}$ |
| :---: | :---: | :---: | :---: |
| Bank A | LVDS |  | 3.3 V |
|  | Bank B | LVDS |  |

- Core Supply Current, $I_{C C}=25 \mathrm{~mA}$ (maximum)

Output Supply Current, Bank A Current $=0.07 \mathrm{~mA} \times 125 \mathrm{MHz}+30 \mathrm{~mA}=38.75 \mathrm{~mA}$
Output Supply Current, Bank B Current $=0.07 \mathrm{~mA} \times 125 \mathrm{MHz}+30 \mathrm{~mA}=38.75 \mathrm{~mA}$

- Total Device Current $=25 \mathrm{~mA}+38.75 \mathrm{~mA}+38.75 \mathrm{~mA}=102.5 \mathrm{~mA}$
- Total Device Power $=3.465 \mathrm{~V} * 102.5 \mathrm{~mA}=355.2 \mathrm{~mW}$ or 0.3552 W

With an ambient temperature of $85^{\circ} \mathrm{C}$ and no airflow, the junction temperature is:
$\mathrm{T}_{\mathrm{J}}=85^{\circ} \mathrm{C}+35.23^{\circ} \mathrm{C} / \mathrm{W} * 0.3552 \mathrm{~W}=97.5^{\circ} \mathrm{C}$

## LVDS Power Considerations

This section provides information on power dissipation and junction temperature for the 8P391208.
Equations and example calculations are also provided.

## 1. Power Dissipation.

The total power dissipation for the 8P391208 is the sum of the core power plus the power dissipated in the load(s).
The following is the power dissipation for $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}+5 \%=3.465 \mathrm{~V}$, which gives worst case results.

- Power (core) $)_{\text {max }}=V_{\text {CC_max }}{ }^{*} I_{\text {CC_max }}=3.465 \mathrm{~V} * 25 \mathrm{~mA}=86.625 \mathrm{~mW}$
- Power (outputs) max $=\mathrm{V}_{\text {CCO_max }}{ }^{*} \mathrm{I}_{\text {CCO_maX }}=3.465 \mathrm{~V} * 157 \mathrm{~mA}=544.005 \mathrm{~mW}$
- Total Power_max $=86.625 \mathrm{~mW}+544.005 \mathrm{~mW}=630.63 \mathrm{~mW}$


## 2. Junction Temperature.

Junction temperature, Tj , is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is $125^{\circ} \mathrm{C}$. Limiting the internal transistor junction temperature, Tj , to $125^{\circ} \mathrm{C}$ ensures that the bond wire and bond pad temperature remains below $125^{\circ} \mathrm{C}$.

The equation for Tj is as follows: $\mathrm{Tj}=\theta_{\mathrm{JA}} *$ Pd_total $+\mathrm{T}_{\mathrm{A}}$
$\mathrm{Tj}=$ Junction Temperature
$\theta_{\mathrm{JA}}=$ Junction-to-Ambient Thermal Resistance
Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)
$\mathrm{T}_{\mathrm{A}}=$ Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance $\theta_{\mathrm{JA}}$ must be used. Assuming no air flow and a multi-layer board, the appropriate value is $35.23^{\circ} \mathrm{C} / \mathrm{W}$ per Table 38 below.

Therefore, Tj for an ambient temperature of $85^{\circ} \mathrm{C}$ with all outputs switching is:
$85^{\circ} \mathrm{C}+0.631 \mathrm{~W} * 35.23^{\circ} \mathrm{C} / \mathrm{W}=107.2^{\circ} \mathrm{C}$. This is below the limit of $125^{\circ} \mathrm{C}$.
This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 38: Thermal Resistance $\theta_{J A}$ for 32 -lead $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ VFQFN, Forced Convection

| $\theta_{\mathrm{JA}}$ by Velocity |  |  |  |
| :--- | :---: | :---: | :---: |
| Meters per Second | 0 | 1 | 2 |
| Multi-Layer PCB, JEDEC Standard Test Boards | $35.23^{\circ} \mathrm{C} / \mathrm{W}$ | $31.6^{\circ} \mathrm{C} / \mathrm{W}$ | $30.0^{\circ} \mathrm{C} / \mathrm{W}$ |

## LVPECL Power Considerations

This section provides information on power dissipation and junction temperature for the 8P391208.
Equations and example calculations are also provided.

## 1. Power Dissipation.

The total power dissipation for the 8P391208 is the sum of the core power plus the power dissipated in the load(s).
The following is the power dissipation for $\mathrm{V}_{\mathrm{CC}}+5 \%=3.465 \mathrm{~V}$, which gives worst case results.
NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core) $)_{\text {MAX }}=\mathrm{V}_{\text {CC_MAX }}{ }^{*} \mathrm{I}_{\text {CC_MAX }}=3.465 \mathrm{~V} * 128.1 \mathrm{~mA}=443.9 \mathrm{~mW}$
- Power (outputs) ${ }_{\text {MAX }}=27.95 \mathrm{~mW} /$ Loaded Output pair If all outputs are loaded, the total power is 8 * $27.95 \mathrm{~mW}=223.6 \mathrm{~mW}$
- Total Power_max $(3.465 \mathrm{~V}$, with all outputs switching $)=443.9 \mathrm{~W}+223.6 \mathrm{~mW}=667.5 \mathrm{~mW}$


## 2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is $125^{\circ} \mathrm{C}$. Limiting the internal transistor junction temperature, Tj , to $125^{\circ} \mathrm{C}$ ensures that the bond wire and bond pad temperature remains below $125^{\circ} \mathrm{C}$.

The equation for $\mathrm{Tj}_{\mathrm{j}}$ is as follows: $\mathrm{Tj}=\theta_{\mathrm{JA}}$ * Pd _total $+\mathrm{T}_{\mathrm{A}}$
$\mathrm{T} \mathrm{j}=$ Junction Temperature
$\theta_{\text {JA }}=$ Junction-to-Ambient Thermal Resistance
Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)
$\mathrm{T}_{\mathrm{A}}=$ Ambient Temperature
In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance $\theta_{\mathrm{JA}}$ must be used. Assuming no air flow and a multi-layer board, the appropriate value is $35.23^{\circ} \mathrm{C} / \mathrm{W}$ per Table 39 below.

Therefore, Tj for an ambient temperature of $85^{\circ} \mathrm{C}$ with all outputs switching is:
$85^{\circ} \mathrm{C}+0.6675 \mathrm{~W} * 35.23^{\circ} \mathrm{C} / \mathrm{W}=108.5^{\circ} \mathrm{C}$. This is below the limit of $125^{\circ} \mathrm{C}$.
This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 39: Thermal Resistance $\theta_{J A}$ for 32 -lead $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ VFQFN, Forced Convection

| $\theta_{\mathrm{JA}}$ by Velocity |  |  |  |
| :--- | :---: | :---: | :---: |
| Meters per Second | 0 | 1 | 2 |
| Multi-Layer PCB, JEDEC Standard Test Boards | $35.23^{\circ} \mathrm{C} / \mathrm{W}$ | $31.6^{\circ} \mathrm{C} / \mathrm{W}$ | $30.0^{\circ} \mathrm{C} / \mathrm{W}$ |

## 3. Calculations and Equations.

The purpose of this section is to calculate the power dissipation for the LVPECL output pair.
LVPECL output driver circuit and termination are shown in Figure 24.
Figure 24: LVPECL Driver Circuit and Termination


To calculate power dissipation per output pair due to loading, use the following equations which assume a $50 \Omega$ load, and a termination voltage of $\mathrm{V}_{\mathrm{CCO}}-2 \mathrm{~V}$.

- For logic high, $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\mathrm{OH} \text { _MAX }}=\mathrm{V}_{\text {CCO_MAX }}-\mathbf{0 . 8 V}$ $\left(\mathrm{V}_{\text {CCO_MAX }}-\mathrm{V}_{\text {OH_MAX }}\right)=\mathbf{0 . 8} \mathrm{V}$
- For logic low, $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\mathrm{OL} \text {-MAX }}=\mathrm{V}_{\text {CCO_MAX }} \mathbf{- 1 . 7 5 V}$ $\left(\mathrm{V}_{\mathrm{CCO}} \mathrm{MAX}-\mathrm{V}_{\mathrm{OL}} \mathrm{MAX}\right)=1.75 \mathrm{~V}$

Pd _H is power dissipation when the output drives high.
$\mathrm{Pd} \_\mathrm{L}$ is the power dissipation when the output drives low.

Pd_H $=\left[\left(\mathrm{V}_{\text {OH_MA }}-\left(\mathrm{V}_{\text {CCO_MA }}-2 \mathrm{~V}\right)\right) / \mathrm{R}_{\mathrm{L}}\right] *\left(\mathrm{~V}_{\text {CCO_MA }}-\mathrm{V}_{\text {OH_MAX }}\right)=\left[\left(2 \mathrm{~V}-\left(\mathrm{V}_{\text {CCO_MAX }}-\mathrm{V}_{\text {OH_MAX }}\right)\right) / R_{\mathrm{L}}\right] *\left(\mathrm{~V}_{\text {CCO_MAX }}-\mathrm{V}_{\text {OH_MAX }}\right)=$ $[(2 \mathrm{~V}-0.8 \mathrm{~V}) / 50 \Omega]$ * $0.8 \mathrm{~V}=19.2 \mathrm{~mW}$

Pd_L $=\left[\left(V_{\text {OL_MAX }}-\left(V_{\text {CCO_MAX }}-2 V\right)\right) / R_{L}\right] *\left(V_{C C O \_M A ~}-V_{\text {OL_MAX }}\right)=\left[\left(2 V-\left(V_{C C O \_M A X}-V_{O L \_M A X}\right)\right) / R_{L}\right] *\left(V_{C C O \_M A X}-V_{O L \_M A X}\right)=$ $[(2 \mathrm{~V}-1.75 \mathrm{~V}) / 50 \Omega]$ * $1.75 \mathrm{~V}=8.75 \mathrm{~mW}$

Total Power Dissipation per output pair $=$ Pd_H + Pd_L $=\mathbf{2 7 . 9 5 m W}$

## HCSL Power Considerations

This section provides information on power dissipation and junction temperature for the 8P391208.
Equations and example calculations are also provided.

## 1. Power Dissipation.

The total power dissipation for the 8P391208 is the sum of the core power plus the power dissipated in the load(s).
The following is the power dissipation for $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}+5 \%=3.465 \mathrm{~V}$, which gives worst case results.
NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core) MAX $=\mathrm{V}_{\text {CC_MAX }}{ }^{*} \mathrm{I}_{\text {CC_MAX }}=3.465 \mathrm{~V} * 23.60 \mathrm{~mA}=81.774 \mathrm{~mW}$
- Power (outputs) MAX $=44.5 \mathrm{~mW} /$ Loaded Output pair

If all outputs are loaded, the total power is $8 * 44.5 \mathrm{~mW}=356.0 \mathrm{~mW}$

- Total Power_max $=81.774 \mathrm{~mW}+356.0 \mathrm{~mW}=437.77 \mathrm{~mW}$


## 2. Junction Temperature.

Junction temperature, Tj , is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is $125^{\circ} \mathrm{C}$. Limiting the internal transistor junction temperature, Tj , to $125^{\circ} \mathrm{C}$ ensures that the bond wire and bond pad temperature remains below $125^{\circ} \mathrm{C}$.

The equation for Tj is as follows: $\mathrm{Tj}=\theta_{\mathrm{JA}} *$ Pd_total $+\mathrm{T}_{\mathrm{A}}$
$\mathrm{Tj}=$ Junction Temperature
$\theta_{\mathrm{JA}}=$ Junction-to-Ambient Thermal Resistance
Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)
$\mathrm{T}_{\mathrm{A}}=$ Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance $\theta_{\mathrm{JA}}$ must be used. Assuming no air flow and a multi-layer board, the appropriate value is $35.23^{\circ} \mathrm{C} / \mathrm{W}$ per Table 40 below.

Therefore, Tj for an ambient temperature of $85^{\circ} \mathrm{C}$ with all outputs switching is:
$85^{\circ} \mathrm{C}+0.4378 \mathrm{~W} * 35.23^{\circ} \mathrm{C} / \mathrm{W}=100.42^{\circ} \mathrm{C}$. This is below the limit of $125^{\circ} \mathrm{C}$.
This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 40: Thermal Resistance $\theta_{J A}$ for 32 -lead $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ VFQFN, Forced Convection

| $\theta_{\text {JA }}$ by Velocity |  |  |  |
| :--- | :---: | :---: | :---: |
| Meters per Second | 0 | 1 | 2 |
| Multi-Layer PCB, JEDEC Standard Test Boards | $35.23^{\circ} \mathrm{C} / \mathrm{W}$ | $31.6^{\circ} \mathrm{C} / \mathrm{W}$ | $30.0^{\circ} \mathrm{C} / \mathrm{W}$ |

## 3. Calculations and Equations.

The purpose of this section is to calculate power dissipation on the IC per HCSL output pair.
HCSL output driver circuit and termination are shown in Figure 25.
Figure 25: HCSL Driver Circuit and Termination


HCSL is a current steering output which sources a maximum of 17 mA of current per output. To calculate worst case on-chip power dissipation, use the following equations which assume a $50 \Omega$ load to ground.

The highest power dissipation occurs when $\mathrm{V}_{\mathrm{CCO}}$ _ max.

$$
\begin{aligned}
\text { Power } & =\left(V_{\text {CCO_MAX }}-V_{\text {OUT }}\right) * I_{\text {OUT }}, \text { since } V_{\text {OUT }}-I_{\text {OUT }} * R_{\text {L }} \\
& =\left(V_{\text {CCO_MAX }} I_{\text {OUT }} R_{L}\right) * I_{\text {OUT }} \\
& =(3.465 \mathrm{~V}-17 \mathrm{~mA} * 50 \Omega) * 17 \mathrm{~mA}
\end{aligned}
$$

Total Power Dissipation per output pair $=44.5 \mathrm{~mW}$

## CML Power Considerations ( 400 mV - 800 mV )

This section provides information on power dissipation and junction temperature for the 8P391208.
Equations and example calculations are also provided.

## 1. Power Dissipation.

The total power dissipation for the 8 P391208 is the sum of the core power plus the power dissipation in the load(s). The following is the power dissipation for $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}+5 \%=3.465 \mathrm{~V}$, which gives worst case results.
NOTE: Please refer to Section 3 for details on calculating power dissipation in the load.

- Power (core) MAX $=\mathrm{V}_{\text {CC_MAX }}{ }^{*} I_{\text {CC_MAX }}=3.465 \mathrm{~V} * 26.35 \mathrm{~mA}=91.30 \mathrm{~mW}$
- Power (outputs) MAX $=\mathrm{V}_{\text {CCO_MAX }}{ }^{*} \mathrm{I}_{\mathrm{CCO}} \mathrm{MAX}=3.465 \mathrm{~V} * 68.66 \mathrm{~mA}=237.91 \mathrm{~mW}$ If all outputs are loaded, the total power is $8 * 56.03 \mathrm{~mW}=448.24 \mathrm{~mW}$
- Total Power_max $(3.465 \mathrm{~V}$, with all outputs switching $)=91.30 \mathrm{~mW}+237.91 \mathrm{~mW}+448.24 \mathrm{~mW}=777.45 \mathrm{~mW}$


## 2. Junction Temperature.

Junction temperature, Tj , is the temperature at the junction of the bond wire and bond pad, and directly affects the reliability of the device. The maximum recommended junction temperature is $125^{\circ} \mathrm{C}$. Limiting the internal transistor junction temperature, Tj , to $125^{\circ} \mathrm{C}$ ensures that the bond wire and bond pad temperature remains below $125^{\circ} \mathrm{C}$.

The equation for Tj is as follows: $\mathrm{Tj}=\theta_{\mathrm{JA}} *$ Pd_total $+\mathrm{T}_{\mathrm{A}}$
$\mathrm{Tj}=$ Junction Temperature
$\theta_{\mathrm{JA}}=$ Junction-to-Ambient Thermal Resistance
Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)
$\mathrm{T}_{\mathrm{A}}=$ Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance $\theta_{\mathrm{JA}}$ must be used. Assuming no air flow and a multi-layer board, the appropriate value is $35.23^{\circ} \mathrm{C} / \mathrm{W}$ per Table 41 below.

Therefore, Tj for an ambient temperature of $85^{\circ} \mathrm{C}$ with all outputs switching is:
$85^{\circ} \mathrm{C}+0.777 \mathrm{~W} * 35.23^{\circ} \mathrm{C} / \mathrm{W}=112.4^{\circ} \mathrm{C}$. This is well below the limit of $125^{\circ} \mathrm{C}$.
This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 41: Thermal Resistance $\theta_{J A}$ for 32 -lead $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ VFQFN, Forced Convection

| $\theta_{\mathrm{JA}}$ by Velocity |  |  |  |
| :--- | :---: | :---: | :---: |
| Meters per Second | 0 | 1 | 2 |
| Multi-Layer PCB, JEDEC Standard Test Boards | $35.23^{\circ} \mathrm{C} / \mathrm{W}$ | $31.6^{\circ} \mathrm{C} / \mathrm{W}$ | $30.0^{\circ} \mathrm{C} / \mathrm{W}$ |

## 3. Calculations and Equations.

The purpose of this section is to calculate the power dissipation for the CML driver output pair. The CML output circuit and termination are shown in Figure 26.

Figure 26: CML Driver (without built-in $50 \Omega$ pullup) Circuit and Termination


To calculate worst case power dissipation due to the load, use the following equations.

Power dissipation when the output driver is logic LOW:

$$
\begin{aligned}
\text { Pd_L } & =\text { _Load } * V_{-} \text {Output } \\
& =\left(V_{\text {OUT_MAX }} / R_{L}\right) *\left(V_{\text {CCO_MAX }}-V_{\text {OUT_MAX }}\right) \\
& =(1000 \mathrm{mV} / 50 \Omega) *(3.465 \mathrm{~V}-1000 \mathrm{mV}) \\
& =49.3 \mathrm{~mW}
\end{aligned}
$$

Power dissipation when the output driver is logic HIGH:

$$
\begin{aligned}
\text { Pd_H } & =I_{-} \text {Load * V_Output } \\
& =(0.1 \mathrm{~V} / 50 \Omega) *(3.465 \mathrm{~V}-0.1 \mathrm{~V}) \\
& =6.73 \mathrm{~mW}
\end{aligned}
$$

Total Power Dissipation per output pair $=$ Pd_H + Pd_L $=56.03 \mathrm{~mW}$

## Reliability Information

Table 42: $\theta_{\mathrm{JA}}$ vs. Air Flow Table for a 32 -lead $5 \mathrm{~mm} \times 5 \mathrm{~mm}$ VFQFN

| $\theta_{\mathrm{JA}}$ vs. Air Flow |  |  |  |
| :--- | :---: | :---: | :---: |
| Meters per Second | 0 | 1 | 2 |
| Multi-Layer PCB, JEDEC Standard Test Boards | $35.23^{\circ} \mathrm{C} / \mathrm{W}$ | $31.6^{\circ} \mathrm{C} / \mathrm{W}$ | $30.0^{\circ} \mathrm{C} / \mathrm{W}$ |

## Transistor Count

The 8P391208 transistor count is: 6930

## 32-Lead VFQFN Package Outline and Package Dimensions



## 32-Lead VFQFN Package Outline and Package Dimensions (Continued)



## Ordering Information

| Part/Order Number | Marking | Package | Shipping Packaging | Temperature |
| :---: | :---: | :---: | :---: | :---: |
| 8P391208NLGI | IDT8P391208NLGI | 32-lead VFQFN, Lead Free | Tray | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| 8P391208NLGI8 | IDT8P391208NLGI | 32-lead VFQFN, Lead Free | Tape \& Reel, Pin 1 <br> Orientation: EIA-481-C | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |
| 8P391208NLGI/W | IDT8P391208NLGI | 32-lead VFQFN, Lead Free | Tape \& Reel, Pin 1 <br> Orientation: EIA-481-D | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |

Table 43: Pin 1 Orientation in Tape and Reel Packaging

| Part Number Suffix | Pin 1 Orientation | Illustration |
| :---: | :---: | :---: |
| NLGI8 | Quadrant 1 (EIA-481-C) |  |
| NLGI/W | Quadrant 2 (EIA-481-D) |  |

## Revision History

| Revision Date |  |
| :---: | :--- |
| September 1, 2016 | Initial Final datasheet release. |


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